

Notice of References Cited	Application/Control No. 10/737,198	Applicant(s)/Patent Under Reexamination SIWAK ET AL.	
	Examiner Sue A. Weaver	Art Unit 3727	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,759,577	08-1956	JOHN WHITE WILLIAM	190/102
	B	US-4,223,819	09-1980	Wright, Patrick P.	224/153
	C	US-5,581,901	12-1996	Takahashi, Masakatsu	33/756
	D	US-6,043,438	03-2000	Helberg, Gary L.	177/148
	E	US-2003/0127253	07-2003	Heyn, Donald R.	177/148
	F	US-2,518,973	08-1950	ATHERTON ARCHIE P	190/102
	G	US-3,090,454	05-1963	FARRAR CLAYTON L; et. al.	177/131
	H	US-2,710,083	06-1955	JOHN WHITE WILLIAM	190/102
	I	US-3,572,870	03-1971	Marks et al.	312/244
	J	US-1,979,978	11-1934	ALPHONSUS MARTIN PATRICK	190/115
	K	US-944,366	12-1909	KNAPP	190/39
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 03100360 A1	12-2003	PCT	MARKS	
	O	GB 2385142 A	08-2003	United Kingdom	GHOSH, AMAL	G01G 19/58
	P	WO 8404027	10-1984	PCT	KOIVISTO ET SL	
	Q	DE 2721518 B1	02-1978	Germany	Franke et al	
	R	DE 20210055 U1	10-2002	Germany	Munnkert	G01G 19/62
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.